Form PTO-1449 (modified)	Attorney Docket No. ARC920010115US1	Serial No. 10/090,589
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT(S)' INFORMATION DISCLOSURE STATEMENT *(Use several sheets if necessary)*	Applicant(s): Charles T. Rettner et al.	
	Filing Date: 02/28/02	Group Art Unit: Unknown 2655

U. S. Patent Documents

Examiner Initials	Document No.	Date	Name	Class	Subclass	Filing Date
S.N.	5,555,255	9/10/96	Kock et al.	~~372~~	~~96~~	11/24/93
	5,568,504	10/22/96	Kock et al.	~~372~~	~~96~~	11/24/93
	5,583,727	12/10/96	Parkin	~~360~~	~~113~~	05/15/95
	5,625,617	04/29/97	Hopkins et al.	~~365~~	~~124~~	09/06/95
	5,689,480	11/18/97	Kino	~~369~~	~~14~~	08/13/96
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	5,936,808	08/10/99	Huang et al.	~~360~~	~~106~~	11/24/97
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	5,986,978	11/16/99	Rottmayer et al.	~~369~~	~~13~~	11/12/98
	6,016,290	11/18/00	Chen et al.	~~369~~	~~15~~	02/12/99
	6,055,220	04/25/00	Mamin et al.	~~369~~	112	03/31/98
S.N.	6,226,149	05/01/01	Dill, Jr. et al.	~~360~~	~~126~~	12/15/98

Examiner S.N. Date Considered 5-5-05

Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance *and* not considered. Include copy of this form with next communication to applicant(s).

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	Filing Date: 02/28/02	Group Art Unit: ~~Unknown~~ 2655

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Examiner Initials	Document No.	Date	Country	Class	Subclass	Translation Yes No
A.N.	EP -1-008-870-A1	June 14, 2000	Europe	~~G02B~~	~~5/20~~	Application

Examiner A.N. Date Considered 5-5-05

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Examiner Initials	Citation
A.N.	H. J. Rosen et al., *Thermally-Assisted Magnetic Recording*, IBM Technical Disclosure Bulletin, Vol. 40, No.10, October 1997, p. 65.
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A.N.	H. Katayama et al., *New Developments in Laser-Assisted Magnetic Recording,* IEEE Transactions on Magnetics, Vol. 36, No. 1, January 2000, pp. 195-199.

Examiner A. Nguyen **Date C nsidered** 5-5-05

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Examiner Initials	Citation
A.N.	K. E. Johnson et al., *Thin-film media- Current and future technology*, IBM J. of Research & Development, Vol. 40, No. 5, September 1996, pp. 511-536.
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Examiner A. Nguyen **Date Considered** 5-5-05

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Examiner Initials	Citation
A.N.	D. E. Grupp, *Beyond the Bethe Limit: Tunable Enhanced Light Transmission Through a Single Sub-Wavelength Aperture*, Advanced Materials, Vol. 11, No. 10, 1999, pp. 860-862.
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Examiner A. Nguyen **Date Considered** 5-5-05

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LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT(S)' INFORMATION DISCLOSURE STATEMENT *(Use several sheets if necessary)*	Applicant(s):	Charles T. Rettner et al.
	Filing Date: 02/28/02	Group Art Unit: ~~Unknown~~ 2855

Examiner Initials	Citation
A.N.	D. E. Grupp, *Crucial role of metal surface in enhanced transmission through subwavelength apertures*, Applied Physics Letters, Vol. 77, No. 11, September 11, 2000, pp. 1569-1571.
A.N.	R. Sambles, *More than transparent*, Nature, Vol. 391, February 12, 1998, pp. 641-642.
A.N.	H. F. Ghaemi, *Surface plasmons enhance optical transmission through subwavelength holes*, Physical Review B, Vol. 58, No. 11, September 15, 1998, pp. 6779-6782.
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Examin r A.N. Date Considered 5-5-05

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PTO/SB/08A (10-01)
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U.S. Patent and Trademark Office: U.S. DEPARTMENT OF COMMERCE

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(use as many sheets as necessary)

Sheet 1 of 1

Complete if Known	
Application Number	10/090,589
Filing Date	02/28/02
First Named Inventor	Charles T. Rettner et al.
Art Unit	~~2662~~ 2655
Examiner Name	Unassigned
Attorney Docket Number	ARC920010115US1

U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No.[1]	Document Number Number - Kind Code[2] (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		US- 6,351,447	02-26-2002	Takagi et al.	
		US- 5,199,090	03-30-1993	Bell	
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Examiner Signature		Date Considered	5-5-05

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[1] Applicant's unique citation designation number (optional). [2] See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. [3] Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). [4] For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. [5] Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. [6] Applicant is to place a check mark here if English language Translation is attached.

PTO/SB/08A (10-01)
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Sheet 1 of 1

Complete if Known	
Application Number	10/090,589
Filing Date	02/28/2002
First Named Inventor	Charles T. Rettner et al.
Art Unit	~~2852~~ 2655
Examiner Name	Unassigned
Attorney Docket Number	ARC920010115US1

U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No.[1]	Document Number Number - Kind Code[2] (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
S.N.		US- 5,729,641	03-17-1998	Chandonnet et al.	
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